

25AA010A/25LC010A 25AA020A/25LC020A 25AA040A/25LC040A 25AA080A/25LC080A 25AA080B/25LC080B 25AA160A/25LC160A 25AA160B/25LC160B 25AA320A/25LC320A 25AA640A/25LC640A 25AA128/25LC128 25AA256/25LC256 25AA512/25LC512 25AA1024/25LC1024

SPI Serial EEPROM Family Data Sheet

Features:

- Max Clock Speed
 - 10 MHz (1K-256K)
 - 20 MHz (512K-1M)
- · Byte and Page-level Write Operations
- Low-power CMOS Technology
 - Typical Write current: 5 mA
 - Typical Read current: 5 mA @ 10 MHz
 - 7 mA @ 20 MHz
 - Typical Standby current: 1 μA
- Write Cycle Time: 5 ms max.

6 ms max. (25XX1024)

- Self-timed Erase and Write Cycles
- Erase Functions (25XX512 and 25XX1024)
 - Page Erase: 6 ms max.
 - Sector Erase: 15 ms max.
 - Chip Erase: 15 ms max.
- Built-in Write Protection
 - Power on/off data protection circuitry
 - Write enable latch
 - Write-protect pin
- Block/Sector Write Protection
 - Protect none, 1/4, 1/2 or all of array
- Sequential Read
- High Reliability
 - Data retention: > 200 years
 - ESD protection: > 4000V
 - Endurance > 1M Erase/Write Cycles
- · Available in Standard 8-pin and 6-pin Packages
- Temperature Ranges Supported:

2007 Microchip Technology Inc.

c.com

- Industrial (I): -40°C to +85°C
- Automotive (E): -40°C to +125°C

Pin Function Table

Name	Function			
CS	Chip Select			
SO	Serial Data Output			
WP	Write-Protect			
Vss	Ground			
SI	Serial Data Input			
SCK	Serial Clock Input			
HOLD	Hold Input			
Vcc	Supply Voltage			

Description:

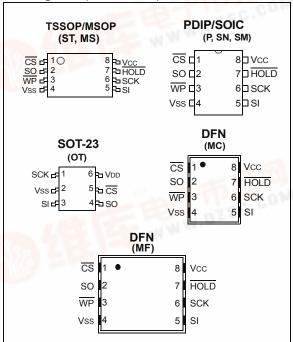
Microchip Technology Inc. supports the Serial Peripheral Interface (SPI) compatible serial bus architecture with low-voltage serial Electrically Erasable PROMs (EEPROM) that range in density from 1 Kbits up to 1 Mbits. Byte-level and page-level functions are supported, but the higher density 512 Kbit and 1 Mbit devices also feature Sector and Chip erase functions typically associated with Flash-based products.

The bus signals required are a clock input (SCK) plus separate data in (SI) and data out (SO) lines. Access to the device is controlled through a Chip Select $\overline{(CS)}$ input.

Communication to the device can be paused via the hold pin (HOLD). While the device is paused, transitions on its inputs will be ignored, with the exception of Chip Select, allowing the host to service higher priority interrupts.

The entire series of SPI compatible devices are available in the standard 8-lead PDIP and SOIC packages, as well as the more advanced packages such as the 8-lead TSSOP, MSOP, 2x3 DFN, 5x6 DFN and 6-lead SOT-23. All packages are RoHS compliant with a Pb-free (Matte Tin) finish.

Pin Diagrams (not to scale)



查询25AA128供应商

DEVICE SELECTION TABLE

Part Number	Density (bits)	Organization	Vcc Range	Max Speed (MHz)	Page Size (Bytes)	Temp. Range	Packages
25LC010A	1K	128 x 8	2.5-5.5V	10	16	I, E	P, MS, SN, ST, MC, OT
25AA010A	1K	128 x 8	1.8-5.5V	10	16	Ι	P, MS, SN, ST, MC, OT
25LC020A	2K	256 x 8	2.5-5.5V	10	16	I, E	P, MS, SN, ST, MC, OT
25AA020A	2K	256 x 8	1.8-5.5V	10	16	I	P, MS, SN, ST, MC, OT
25LC040A	4K	512 x 8	2.5-5.5V	10	16	I, E	P, MS, SN, ST, MC, OT
25AA040A	4K	512 x 8	1.8-5.5V	10	16	I	P, MS, SN, ST, MC, OT
25LC080A	8K	1024 x 8	2.5-5.5V	10	16	I, E	P, MS, SN, ST
25AA080A	8K	1024 x 8	1.8-5.5V	10	16	Ι	P, MS, SN, ST
25LC080B	8K	1024 x 8	2.5-5.5V	10	32	I, E	P, MS, SN, ST
25AA080B	8K	1024 x 8	1.8-5.5V	10	32	I	P, MS, SN, ST
25LC160A	16K	2048 x 8	2.5-5.5V	10	16	I, E	P, MS, SN, ST
25AA160A	16K	2048 x 8	1.8-5.5V	10	16	I	P, MS, SN, ST
25LC160B	16K	2048 x 8	2.5-5.5V	10	32	I, E	P, MS, SN, ST
25AA160B	16K	2048 x 8	1.8-5.5V	10	32	Ι	P, MS, SN, ST
25LC320A	32K	4096 x 8	2.5-5.5V	10	32	I, E	P, MS, SN, ST
25AA320A	32K	4096 x 8	1.8-5.5V	10	32	I	P, MS, SN, ST
25LC640A	64K	8192 x 8	2.5-5.5V	10	32	I, E	P, MS, SN, ST
25AA640A	64K	8192 x 8	1.8-5.5V	10	32	I	P, MS, SN, ST
25LC128	128K	16,384 x 8	2.5-5.5V	10	64	I, E	P, SN, SM, ST, MF
25AA128	128K	16,384 x 8	1.8-5.5V	10	64	I	P, SN, SM, ST, MF
25LC256	256K	32,768 x 8	2.5-5.5V	10	64	I, E	P, SN, SM, ST, MF
25AA256	256K	32,768 x 8	1.8-5.5V	10	64	I	P, SN, SM, ST, MF
25LC512	512K	65,536 x 8	2.5-5.5V	20	128	I, E	P, SM, MF
25AA512	512K	65,536 x 8	1.8-5.5V	20	128	I	P, SM, MF
25LC1024	1024K	131,072 x 8	2.5-5.5V	20	256	I, E	P, SM, MF
25AA1024	1024K	131,072 x 8	1.8-5.5V	20	256	Ι	P, SM, MF

1.0 ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings (†)

Vcc	6.5V
All inputs and outputs w.r.t. Vss	-0.6V to Vcc +1.0V
Storage temperature	65°C to +150°C
Ambient temperature under bias	40°C to +125°C
ESD protection on all pins	

† NOTICE: Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operational listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

Note: This is an overview of AC and DC Characteristics. Please refer to the device data sheet for production specs.

			Electrical 0	Electrical Characteristics:							
DC CHA	RACTER	STICS	Industrial (I	•		V to 5.5V TA = -40°C to +85°					
			Automotive	Automotive (E): $Vcc = +2.5V$ to 5.5V TA = -40°C to 125°C							
Param. No.	Sym.	Characteristic	Min.	Max.	Units	Test Conditions	Densities				
D001	VIH	High-level input voltage	.7 Vcc	Vcc + 1	V		All				
D002	VIL	Low-level input voltage	-0.3	0.3 Vcc	V	Vcc ≥ 2.7V (Note 1)	All				
D003	VIL		-0.3	0.2 Vcc	V	Vcc ≥ 2.7V (Note 1)	All				
D004	Vol	Low-level output voltage	_	0.4	V	IOL = 2.1 mA, VCC = 4.5V	All				
D005	Vol			0.2	V	IOL = 1.0 mA, VCC = 2.5V	All				
D006	Vон	High-level output voltage	Vcc -0.5	_	V	Іон = -400 μА	All				
D007	ILI	Input leakage current	_	±1	μA	CS = Vcc, VIN = Vss or Vcc	All				
D008	Ilo	Output leakage current	_	±1	μA	CS = Vcc, Vout = Vss or Vcc	All				
D009	CINT	Internal capacitance (all inputs and outputs)	-	7	pF	TA = 25°C, CLK = 1.0 MHz, Vcc = 5.0V (Note 1)	All				
D010	Icc Read		-	10 5	mA	Vcc = 5.5V; Fclk = 20.0 MHz; Vcc = 2.5V; Fclk = 10.0 MHz	512K and 1M				
		Operating current	2.5 0.5	6 2.5	mA	Vcc = 5.5V; Fclk = 10.0 MHz; Vcc = 2.5V; Fclk = 5.0 MHz	1K-256K				
D011	ICC WRITE		_	7 5	mA	Vcc = 5.5V Vcc = 2.5V	512K and 1M				
			0.16 0.15	5 3	mA	Vcc = 5.5V Vcc = 2.5V	1K-256K				
D012	Iccs	Standby current	-	20 12	μA	$\frac{\overline{CS}}{\overline{CS}} = Vcc = 5.5V, 125^{\circ}C$ $\overline{CS} = Vcc = 5.5V, 85^{\circ}C$ (Inputs tied to Vcc or Vss)	512K and 1M				
			_	5 1	μA	$\frac{\overline{CS}}{CS} = Vcc = 5.5V, 125^{\circ}C$ $\overline{CS} = Vcc = 5.5V, 85^{\circ}C$ (Inputs tied to Vcc or Vss)	1K-256K				
D13	ICCSPD	Deep power-down current	-	1	μA	CS= Vcc = 5.5V(Inputs tied to Vcc or Vss)	512K and 1M				

TABLE 1-1: DC CHARACTERISTICS

Note 1: This parameter is periodically sampled and not 100% tested.

查询25AA128供应商

TABLE 1-2: AC CHARACTERISTICS

AC CHARACTERISTICS		Electrical C Industrial (I) Automotive	: Vcc =	= +1.8V to	5.5V TA = -40°C to +8 5.5V TA = -40°C to 12		
Param. No.	Sym.	Characteristic	Min.	Max.	Units	Conditions	Densities
1	Fclk	Clock frequency		20 10 2	MHz	$\begin{array}{l} 4.5 \leq VCC \leq 5.5 \\ 2.5 \leq VCC < 4.5 \\ 1.8 \leq VCC < 2.5 \end{array}$	512K and 1M
				10 5 3	MHz	$\begin{array}{l} 4.5 \leq VCC \leq 5.5 \\ 2.5 \leq VCC < 4.5 \\ 1.8 \leq VCC < 2.5 \end{array}$	1K-256K
2	Tcss	CS setup time	25 50 250	_	ns ns ns	$\begin{array}{l} 4.5 \leq VCC \leq 5.5 \\ 2.5 \leq VCC < 4.5 \\ 1.8 \leq VCC < 2.5 \end{array}$	512K and 1M
			50 100 150	_	ns ns ns	$\begin{array}{l} 4.5 \leq VCC \leq 5.5 \\ 2.5 \leq VCC < 4.5 \\ 1.8 \leq VCC < 2.5 \end{array}$	1K-256K
3	Тсѕн	CS hold time (Note 3)	50 100 150		ns ns ns	$\begin{array}{l} 4.5 \leq VCC \leq 5.5 \\ 2.5 \leq VCC < 4.5 \\ 1.8 \leq VCC < 2.5 \end{array}$	512K and 1M
			100 200 250		ns ns ns	$4.5 \le VCC \le 5.5$ $2.5 \le VCC < 4.5$ $1.8 \le VCC < 2.5$	1K-256K
4	TCSD	CS disable time	50		ns		1K-256K
5		Data setup time	5 10 50	_	ns ns ns	$4.5 \le VCC \le 5.5$ $2.5 \le VCC < 4.5$ $1.8 \le VCC < 2.5$	512K and 1M
			10 20 30	_	$\begin{array}{c c c c c c c c c } - & ns & 4.5 \le Vcc \le 5.5 \\ ns & 2.5 \le Vcc < 4.5 \\ ns & 1.8 \le Vcc < 2.5 \end{array}$		1K-256K
6	Thd	Data hold time	10 20 100	_	ns ns ns	$\begin{array}{l} 4.5 \leq VCC \leq 5.5 \\ 2.5 \leq VCC < 4.5 \\ 1.8 \leq VCC < 2.5 \end{array}$	512K and 1M
			20 40 50	_	ns ns ns	$\begin{array}{l} 4.5 \leq VCC \leq 5.5 \\ 2.5 \leq VCC < 4.5 \\ 1.8 \leq VCC < 2.5 \end{array}$	1K-256K
7	TR	CLK rise time	_	20	ns		512K and 1M
		(Note 1)		100	ns		128K and 256K
				500	ns		8K and 16K
				2000	ns		1K-4K, 32K-64K
8	TF	CLK fall time		20	ns		512K and 1M
		(Note 1)	_	100	ns		128K and 256K
				500	ns		8K and 16K
			—	2000	ns		1K-4K, 32K-64K

Note 1: This parameter is periodically sampled and not 100% tested.

2: This parameter is not tested but established by characterization and qualification. For endurance estimates in a specific application, please consult the Total Endurance™ Model, which can be obtained from Microchip's web site: www.microchip.com.

3: Includes THI time.

TABLE 1-2: AC CHARACTERISTICS (CONTINUED)

AC CHARACTERISTICS			Electrical Characteristics:Industrial (I): $Vcc = +1.8V$ to 5.5VTA = -40°C to +85°CAutomotive (E): $Vcc = +2.5V$ to 5.5VTA = -40°C to 125°C						
Param. No.	Sym.	Characteristic	Min.	Max.	Units	Conditions	Densities		
9	Тні	Clock high time	25 50 250	_	ns ns ns	$\begin{array}{l} 4.5 \leq VCC \leq 5.5 \\ 2.5 \leq VCC < 4.5 \\ 1.8 \leq VCC < 2.5 \end{array}$	512K and 1M		
			50 100 150	_	ns ns ns	$4.5 \le Vcc \le 5.5$ $2.5 \le Vcc < 4.5$ $1.8 \le Vcc < 2.5$	1K-256K		
10	Tlo	Clock low time	25 50 250	_	ns ns ns	$4.5 \le VCC \le 5.5$ $2.5 \le VCC < 4.5$ $1.8 \le VCC < 2.5$	512K and 1M		
			50 100 150	_	ns ns ns	$4.5 \le VCC \le 5.5$ $2.5 \le VCC < 4.5$ $1.8 \le VCC < 2.5$	1K-256K		
11	TCLD	Clock delay time	50		ns		All		
12	TCLE	Clock enable time	50	_	ns		All		
13 Tv	Output valid from clock low	_	25 50 250	ns ns ns	$\begin{array}{l} 4.5 \leq VCC \leq 5.5 \\ 2.5 \leq VCC < 4.5 \\ 1.8 \leq VCC < 2.5 \end{array}$	512K and 1M			
			_	50 100 160	ns ns ns	$\begin{array}{l} 4.5 \leq VCC \leq 5.5 \\ 2.5 \leq VCC < 4.5 \\ 1.8 \leq VCC < 2.5 \end{array}$	1K-256K		
14	Тно	Output hold time (Note 1)	0	—	ns				
15	TDIS	Output disable time (Note 1)	_	25 50 250	ns ns ns	$4.5 \le VCC \le 5.5$ $2.5 \le VCC < 4.5$ $1.8 \le VCC < 2.5$	512K and 1M		
			_	40 80 160	ns ns ns	$\begin{array}{l} 4.5 \leq VCC \leq 5.5 \\ 2.5 \leq VCC < 4.5 \\ 1.8 \leq VCC < 2.5 \end{array}$	1K-256K		
16	THS	HOLD setup time	10 20 100	_	ns ns ns	$4.5 \le VCC \le 5.5$ $2.5 \le VCC < 4.5$ $1.8 \le VCC < 2.5$	512K and 1M		
			20 40 80	_	ns ns ns	$4.5 \le VCC \le 5.5$ $2.5 \le VCC < 4.5$ $1.8 \le VCC < 2.5$	1K-256K		
17	Тнн	HOLD Hold time	10 20 100	_	ns ns ns	$\begin{array}{l} 4.5 \leq VCC \leq 5.5 \\ 2.5 \leq VCC < 4.5 \\ 1.8 \leq VCC < 2.5 \end{array}$	512K and 1M		
			20 40 80	_	ns ns ns	4.5 ≤ Vcc ≤ 5.5 2.5 ≤ Vcc < 4.5 1.8 ≤ Vcc < 2.5	1K-256K		

Note 1: This parameter is periodically sampled and not 100% tested.

2: This parameter is not tested but established by characterization and qualification. For endurance estimates in a specific application, please consult the Total Endurance[™] Model, which can be obtained from Microchip's web site: www.microchip.com.

3: Includes THI time.

查询25AA128供应商

TABLE 1-2: AC CHARACTERISTICS (CONTINUED)

AC CHARACTERISTICS			Electrical Characteristics:Industrial (I):Vcc = +1.8V to 5.5VTA = -40°C to +85°CAutomotive (E):Vcc = +2.5V to 5.5VTA = -40°C to 125°C						
Param. No.	Sym.	Characteristic	Min.	Max.	Units	Conditions	Densities		
18	Тнг	HOLD low to output High-Z (Note 1)	15 30 150	_	ns ns ns	$\begin{array}{l} 4.5 \leq VCC \leq 5.5 \\ 2.5 \leq VCC < 4.5 \\ 1.8 \leq VCC < 2.5 \end{array}$	512K and 1M		
			30 60 160	_	ns ns ns	$4.5 \le VCC \le 5.5$ $2.5 \le VCC < 4.5$ $1.8 \le VCC < 2.5$	1K-256K		
19	Тну	HOLD high to output valid	15 30 150	_	ns ns ns	$4.5 \le VCC \le 5.5$ $2.5 \le VCC < 4.5$ $1.8 \le VCC < 2.5$	512K and 1M		
			30 60 160	_	ns ns ns	$4.5 \le VCC \le 5.5$ $2.5 \le VCC < 4.5$ $1.8 \le VCC < 2.5$	1K-256K		
20	Trel	CS high to Standby mode	_	100	μS	$1.8V \le VCC \ge 5.5V$	512K and 1M		
21	Tpd	CS high to Deep power-down		100	μS	$1.8V \le VCC \ge 5.5V$	512K and 1M		
22	TCE	Chip erase cycle time	_	15	ms	$1.8V \le VCC \ge 5.5V$	512K and 1M		
23	TSE	Sector erase cycle time	—	15	ms	$1.8V \le VCC \ge 5.5V$	512K and 1M		
24	Twc	Internal write cycle time	_	6	ms	Byte or Page mode and Page Erase	512K and 1M		
			—	5	ms	Byte or Page mode	1K-256K		
25		Endurance (Note 2)	> 1M	—	E/W Cycles	Per Page Per Byte	512K and 1M 1K-256K		

Note 1: This parameter is periodically sampled and not 100% tested.

2: This parameter is not tested but established by characterization and qualification. For endurance estimates in a specific application, please consult the Total Endurance[™] Model, which can be obtained from Microchip's web site: www.microchip.com.

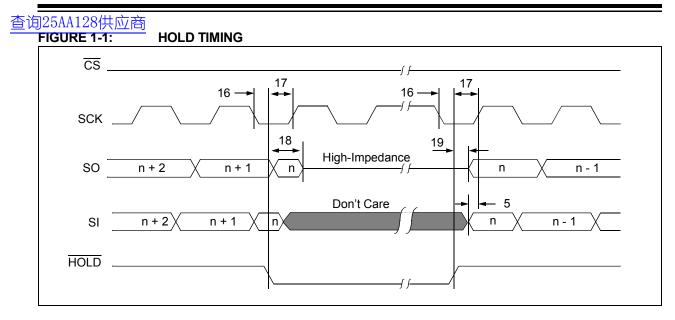
3: Includes THI time.

TABLE 1-3: AC TEST CONDITIONS

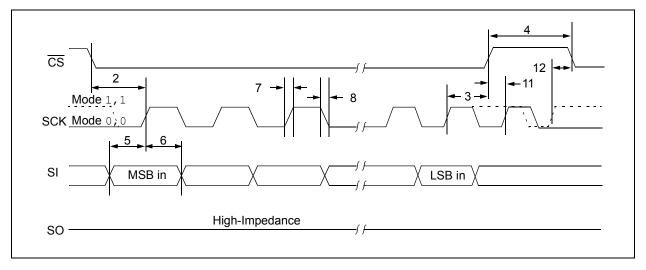
AC Waveform:					
VLO = 0.2V					
VHI = VCC - 0.2V	(Note 1)				
VHI = 4.0V	(Note 2)				
CL = 30 pF	_				
Timing Measurement Reference Level					
Input	0.5 Vcc				
Output	0.5 Vcc				

Note 1: For VCC ≤ 4.0 V.

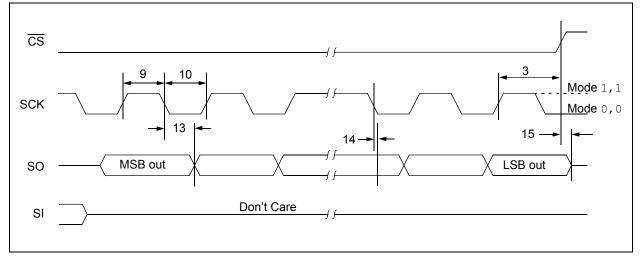
2: For Vcc > 4.0V.











查询25AA128供应商 2.0 FUNCTIONAL DESCRIPTION

2.1 Principles of Operation

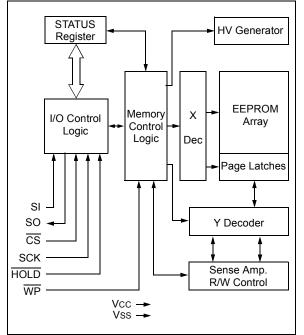
The 25-Series of Serial EEPROMs is designed to interface directly with the Serial Peripheral Interface (SPI) port of many of today's popular microcontroller families, including Microchip's PIC[®] microcontrollers. It may also interface with microcontrollers that do not have a built-in SPI port by using discrete I/O lines programmed properly in firmware to match the SPI protocol.

This family of EEPROMs contains an 8-bit instruction register. The device is accessed via the SI pin, with data being clocked in on the rising edge of SCK. The CS pin must be low and the HOLD pin must be high for the entire operation.

Table 2-1 contains a list of the possible instruction bytes and format for device operation. All instructions, addresses and data are transferred MSB first, LSB last.

Data <u>(SI)</u> is sampled on the first rising edge of SCK after CS goes low. If the clock line is shared with other peripheral devices on the SPI bus, the user can assert the HOLD input and place the EEPROM in 'HOLD' mode. After releasing the HOLD pin, operation will resume from the point when the HOLD was asserted.

Block Diagram



Instruction Name	Instruction Format	Description						
	Instructions for all devices.							
READ	0000 0011	Read data from memory array beginning at selected address						
WRITE	0000 0010	Write data to memory array beginning at selected address						
WREN	0000 0110	Set the write enable latch (enable write operations)						
WRDI	0000 0100	Reset the write enable latch (disable write operations)						
RDSR	0000 0101	Read STATUS register						
WRSR	0000 0001	Write STATUS register						
	Additional Instru	ctions for 25XX512 and 25XX1024						
PE	0100 0010	Page Erase – erase one page in memory array						
SE	1101 1000	Sector Erase – erase one sector in memory array						
CE	1100 0111	Chip Erase – erase all sectors in memory array						
RDID	1010 1011	Release from Deep power-down and read electronic signature						
DPD	1011 1001	Deep Power-Down mode						

TABLE 2-1: INSTRUCTION SET

2.2 Read Sequence

The device is selected by pulling \overline{CS} low. The 8-bit READ instruction is transmitted to the EEPROM followed by the address. After the correct READ instruction and address are sent, the data stored in the memory at the selected address is shifted out on the SO pin. The data stored in the memory at the next address can be read sequentially by continuing to provide clock pulses.

The internal Address Pointer is automatically incremented to the next higher address after each byte of data is shifted out. When the highest address is reached, the address counter rolls over to address 00000h, allowing the read cycle to be continued indefinitely. The read operation is terminated by raising the $\overline{\text{CS}}$ pin. See Figure 2-1A/B/C for byte read.

查询25AA128供应商 TABLE 2-2: READ/WRITE SEQUENCE ADDRESSING

Density	Address Bits	Highest Address	Page Size
1K	7	007F	16 Bytes
2K	8	00FF	16 Bytes
4K	9	01FF	16 Bytes
8K	10	03FF	16 or 32 Bytes*
16K	11	07FF	16 or 32 Bytes*
32K	12	0FFF	32 Bytes
64K	12	1FFF	32 Bytes
128K	14	3FFF	64 Bytes
256K	15	7FFF	64 Bytes
512K	16	FFFF	256 Bytes
1024K	17	1FFFF	256 Bytes
Note:	Version A -	- 16 Bytes	

Version A – 16 Bytes Version B – 32 Bytes

FIGURE 2-1A: READ SEQUENCE WITH EITHER 8-BIT OR 9-BIT ADDRESSING

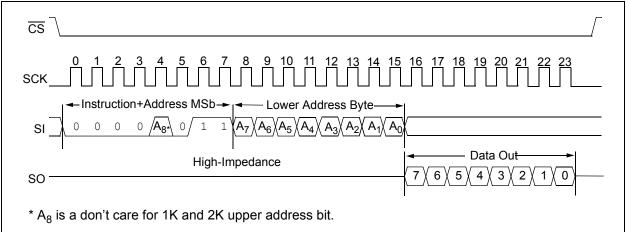
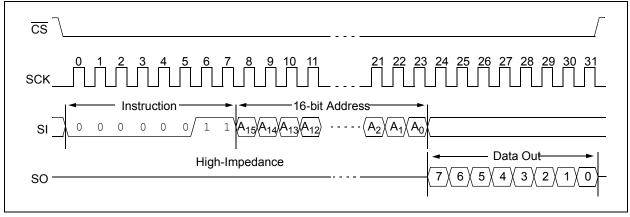
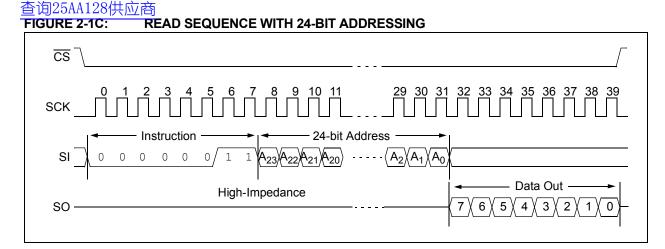


FIGURE 2-1B: READ SEQUENCE WITH 16-BIT ADDRESSING





2.3 Write Sequence

Prior to any attempt to write data to the EEPROM, the write enable latch must be set by issuing the WREN instruction (Figure 2-4). This is done by setting CS low and then clocking out the proper instruction into the EEPROM. After all eight bits of the instruction are transmitted, CS must be brought high to set the write enable latch. If the write operation is initiated immediately after the WREN instruction without CS being brought high, the data will not be written to the array because the write enable latch will not have been properly set.

A write sequence includes an automatic, self timed erase cycle. It is not required to erase any portion of the memory prior to issuing a Write command.

Once the Write Enable Latch is set, the user may proceed by setting \overline{CS} low, issuing a WRITE instruction, followed by the address and then the data to be written. Depending upon the density, a page of data that ranges from 16 bytes to 256 bytes can be sent to the device before a write cycle is necessary. The only restriction is that all of the bytes must reside in the same page. See Table 2-2 for information on page sizes.

In the 24XX512 and 24XX1024 devices, the entire page is always refreshed regardless of whether the entire page is written. For this reason, endurance for these devices is specified per page.

Note: Page write operations are limited to writing bytes within a single physical page, regardless of the number of bytes actually being written. Physical page boundaries start at addresses that are integer multiples of the page buffer size (or 'page size'), and end at addresses that are integer multiples of page size - 1. If a Page Write command attempts to write across a physical page boundary, the result is that the data wraps around to the beginning of the current page (overwriting data previously stored there), instead of being written to the next page as might be expected. It is therefore necessary for the application software to prevent page write operations that would attempt to cross a page boundary.

For the data to be actually written to the array, CS must be brought high after the Least Significant bit (D0) of the nth data byte has been clocked in. If CS is brought high at any other time, the write operation will not be completed. Refer to Figure 2-2A/B/C and Figure 2-3A/ B/C/D for more detailed illustrations on the byte write sequence and the page write sequence, respectively. While the write is in progress, the STATUS register may be read to check the status of the WIP and WEL bits (Figure 2-6). A read attempt of a memory array location will not be possible during a write cycle. When the write cycle is completed, the write enable latch is reset.

FIGURE 2-2A: BYTE WRITE SEQUENCE WITH EITHER 8-BIT OR 9-BIT ADDRESSING

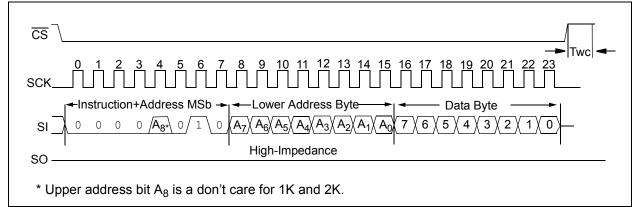


FIGURE 2-2B: BYTE WRITE SEQUENCE WITH 16-BIT ADDRESSING

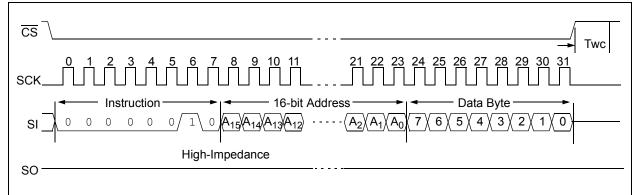
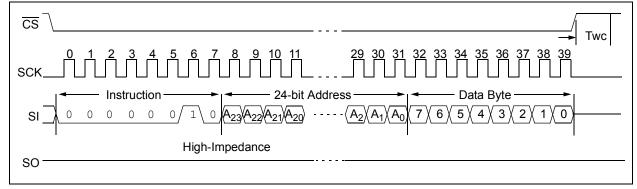


FIGURE 2-2C: BYTE WRITE SEQUENCE WITH 24-BIT ADDRESSING



© 2007 Microchip Technology Inc.

查询25AA128供应商



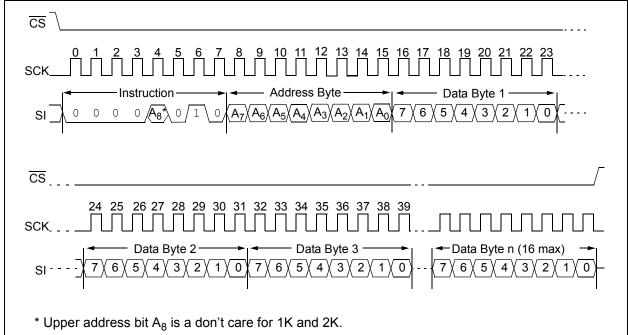
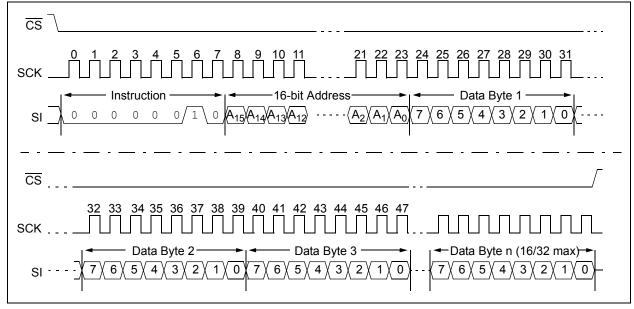
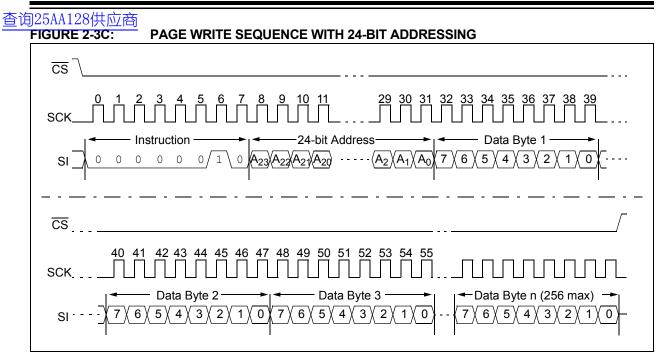


FIGURE 2-3B: PAGE WRITE SEQUENCE WITH 16-BIT ADDRESSING





2.4 Write Enable (WREN) and Write Disable (WRDI)

The EEPROM contains a write enable latch. See Table 2-4 for the Write-Protect Functionality Matrix. This latch must be set before any write operation will be completed internally. The WREN instruction will set the latch, and the WRDI will reset the latch.

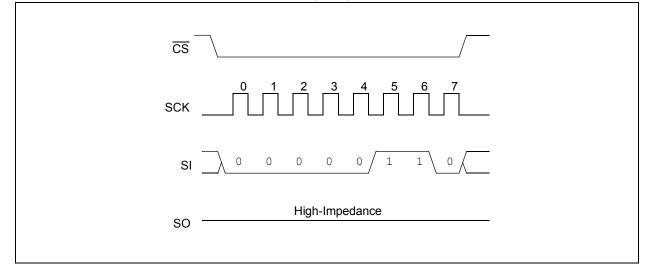
The following is a list of conditions under which the write enable latch will be reset:

- Power-up
- WRDI instruction successfully executed
- WRSR instruction successfully executed
- WRITE instruction successfully executed
- WP pin is brought low (1K, 2K, 4K only)

Additional instructions available on 25XX512 and 25XX1024:

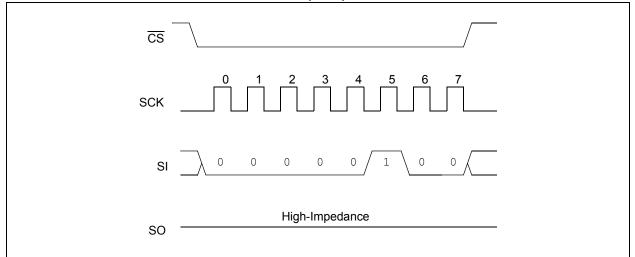
- PE instruction successfully executed
- SE instruction successfully executed
- CE instruction successfully executed

FIGURE 2-4: WRITE ENABLE SEQUENCE (WREN)



查询25AA128供应商

FIGURE 2-5: WRITE DISABLE SEQUENCE (WRDI)



2.5 Read Status Register Instruction (RDSR)

The Read Status Register instruction (RDSR) provides access to the STATUS register. The STATUS register may be read at any time, even during a write cycle. The STATUS register is formatted as follows:

7	6	5	4	3	2	1	0	
W/R				W/R	W/R	R	R	
WPEN	Х	Х	Х	BP1	BP0	WEL	WIP	
W/R = writable/readable. R = read-only.								

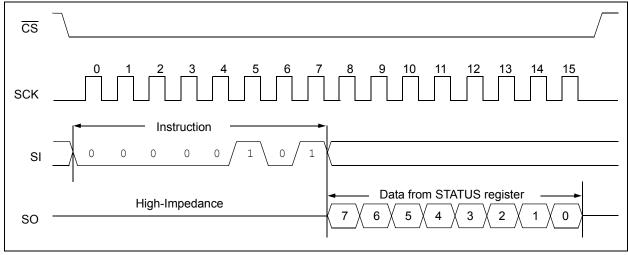
Note: WPEN bit not available in 24XX010A, 24XX020A and 24XX040A devices.

The Write-In-Process (WIP) bit indicates whether the EEPROM is busy with a write operation. When set to a '1', a write is in progress, when set to a '0', no write is in progress. This bit is read-only.

The Write Enable Latch (WEL) bit indicates the status of the write enable latch and is read-only. When set to a '1', the latch allows writes to the array, when set to a '0', the latch prohibits writes to the array. The state of this bit can always be updated via the WREN or WRDI commands regardless of the state of write protection on the STATUS register. These commands are shown in Figure 2-4 and Figure 2-5.

The Block Protection (BP0 and BP1) bits indicate which blocks are currently write-protected. These bits are set by the user issuing the WRSR instruction. These bits are nonvolatile and are shown in Table 2-4. See Figure 2-6 for the RDSR timing sequence.





2.6 Write Status Register Instruction (WRSR)

The Write Status Register instruction (WRSR) allows the user to write to the nonvolatile bits in the STATUS register as shown in Table 2-3. The user is able to select one of four levels of protection for the array by writing to the appropriate bits in the STATUS register. The array is divided up into four segments. The user has the ability to write-protect none, one, two, or all four of the segments of the array. The partitioning is controlled as is shown in Table 2-4.

In EEPROM densities starting at 8 Kbits and higher, the Write-Protect Enable (WPEN) bit is a nonvolatile bit that is available as an enable bit for the WP pin. The Write-Protect (WP) pin and the Write-Protect Enable (WPEN) bit in the STATUS register control the programmable hardware write-protect feature. Hardware write protection is enabled when WP pin is low and the WPEN bit is high. Hardware write protection is disabled when either the WP pin is high or the WPEN bit is low. When the chip is hardware write-protected, only writes to nonvolatile bits in the STATUS register are disabled. See Table 2-6 for a matrix of functionality on the WPEN bit. See Figure 2-7 for the WRSR timing sequence.

BP1	BP0	Array Addresses Write-Protected	Array Addresses Unprotected
0	0	none	All (Sectors 0, 1, 2 and 3)
0	1	Upper 1/4 (Sector 3)	Lower 3/4 (Sectors 0, 1 and 2)
1	0	Upper 1/2 (Sectors 2 and 3)	Lower 1/2 (Sectors 0 and 1)
1	1	All (Sectors 0, 1, 2 and 3)	none

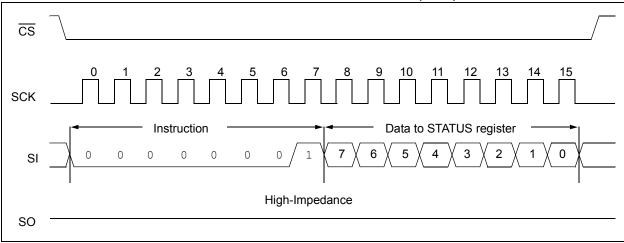
TABLE 2-4:ARRAY PROTECTION

TABLE 2-5: ARRAY PROTECTED ADDRESS LOCATIONS

Density	Upper 1/4 (Sector 3)	Upper 1/2 (Sectors 2 and 3)	All Sectors
1K	60h-7Fh	40h-7Fh	00h-7Fh
2K	C0h-FFh	80h-FFh	00h-FFh
4K	180h-1FFh	100h-1FFh	000h-1FFh
8K	300h-3FFh	200h-3FFh	000h-3FFh
16K	600h-7FFh	400h-7FFh	000h-7FFh
32K	C00h-FFFh	800h-FFFh	000h-FFFh
64K	1800h-1FFFh	1000h-1FFFh	0000h-1FFFh
128K	3000h-3FFFh	2000h-3FFFh	0000h-3FFFh
256K	6000h-7FFFh	4000h-7FFFh	0000h-7FFFh
512K	C000h-FFFFh	8000h-FFFFh	0000h-FFFFh
1024K	18000h-1FFFFh	10000h-1FFFFh	00000h-1FFFFh



WRITE STATUS REGISTER TIMING SEQUENCE (WRSR)



查询25AA128供应商

2.7 Data Protection

The following protection has been implemented to prevent inadvertent writes to the array:

- · The write enable latch is reset on power-up
- A write enable instruction must be issued to set the write enable latch
- After a byte write, page write or STATUS register write, the write enable latch is reset
- CS must be set high after the proper number of clock cycles to start an internal write cycle

• Access to the array during an internal write cycle is ignored and programming is continued

2.8 Power-On State

The Serial EEPROM powers on in the following state:

- The device is in low-power Standby mode ($\overline{CS} = 1$)
- · The write enable latch is reset
- · SO is in high-impedance state
- A high-to-low-level transition on CS is required to enter active State

WEL (SR bit 1)	WPEN (SR bit 7) *	WP (pin 3)	Protected Blocks	Unprotected Blocks	STATUS Register
0	Х	Х	Protected	Protected	Protected
1	0	Х	Protected	Writable	Writable
1	1	0 (low)	Protected	Writable	Protected
1	1	1 (high)	Protected	Writable	Writable
x = Don't Care					

WRITE-PROTECT FUNCTIONALITY MATRIX

* = WPEN bit is not available on 24XX010A/020A/040A.

2.9 Page Erase

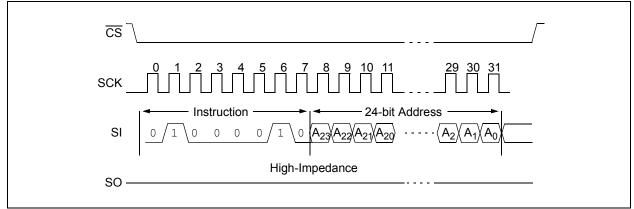
TABLE 2-6:

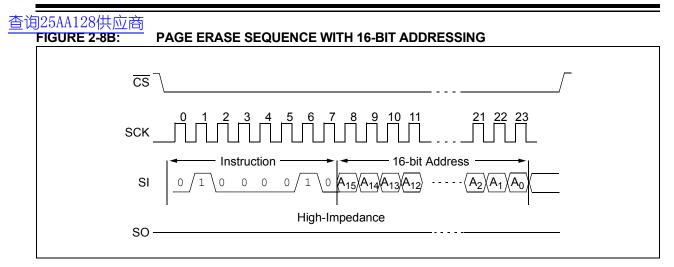
The Page Erase is a typical Flash function that has been implemented only on the 512 Kbit and 1024 Kbit Serial EEPROMs. This function is used to erase all bits (FFh) inside a given page. A Write Enable (WREN) instruction must be given prior to attempting a Page Erase. This is done by setting \overline{CS} low and then clocking out the proper instruction into the EEPROM. After all eight bits of the instruction are transmitted, the \overline{CS} must be brought high to set the write enable latch. The Page Erase function is entered by driving \overline{CS} low, followed by the instruction code (Figure 2-8A/B) and two or three address bytes. Any address inside the page to be erased is a valid address.

 $\overline{\text{CS}}$ must then be driven high after the last bit if the address or the Page Erase will not execute. Once the $\overline{\text{CS}}$ is driven high, the self-timed Page Erase cycle is started. The WIP bit in the STATUS register can be read to determine when the Page Erase cycle is complete.

If a Page Erase function is given to an address that has been protected by the Block Protect bits (BP0, BP1) then the sequence will be aborted and no erase will occur.

FIGURE 2-8A: PAGE ERASE SEQUENCE WITH 24-BIT ADDRESSING





2.10 Sector Erase

The Sector Erase is a typical Flash function that has been implemented only on the 512 Kbit and 1024 Kbit Serial EEPROMs. This function is used to erase all bits (FFh) inside a given sector. A Write Enable (WREN) instruction must be given prior to attempting a Sector Erase. This is done by setting CS low and then clocking out the proper instruction into the EEPROM. After all eight bits of the instruction are transmitted, the CS must be brought high to set the write enable latch.

The Sector Erase function is entered by driving \overline{CS} low, followed by the instruction code (Figure 2-9A/B), and two or three address bytes. Any address inside the sector to be erased is a valid address.

 $\overline{\text{CS}}$ must then be driven high after the last bit if the address or the Sector Erase will not execute. Once the $\overline{\text{CS}}$ is driven high, the self-timed Sector Erase cycle is started. The WIP bit in the STATUS register can be read to determine when the Sector Erase cycle is complete.

If a SECTOR ERASE instruction is given to an address that has been protected by the Block Protect bits (BP0, BP1) then the sequence will be aborted and no erase will occur.

See Table 2-2 and Table 2-3 for Sector Addressing.

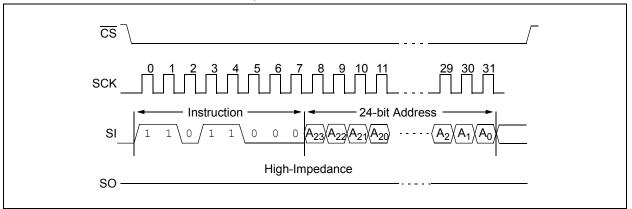


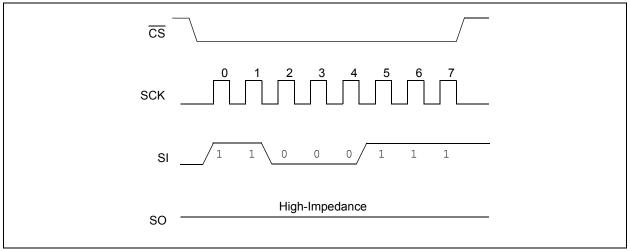
FIGURE 2-9A: SECTOR ERASE SEQUENCE WITH 24-BIT ADDRESSING

2.11 Chip Erase

The Chip Erase function will erase all bits (FFh) in the array. A Write Enable (WREN) instruction must be given prior to executing a Chip Erase. This is done by setting CS low and then clocking out the proper instruction into the EEPROM. After all eight bits of the instruction are transmitted, the CS must be brought high to set the write enable latch. The Chip Erase function is entered by driving the CS low, followed by the instruction code (Figure 2-10) onto the SI line.

The \overline{CS} pin must be driven high after the eighth bit of the instruction code has been given or the Chip Erase function will not be executed. Once the \overline{CS} pin is driven high, the self-timed Chip Erase function begins. While the device is executing the Chip Erase function the WIP bit in the STATUS register can be read to determine when the Chip Erase function is complete. The Chip Erase function is ignored if either of the Block Protect bits (BP0, BP1) are not '0', meaning ¼, ½, or all of the array is protected.

FIGURE 2-10: CHIP ERASE SEQUENCE



2.12 Deep Power-Down Mode

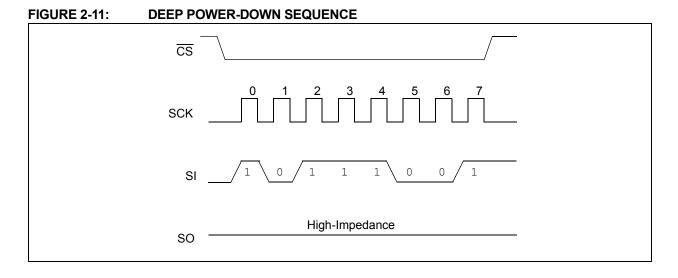
Deep Power-Down mode is available on the high-density 25XX512 and 25XX1024 Serial EEPROMs and is the lowest power consumption state for these devices. While in the Deep Power-Down mode, these devices will not respond to any of the Read or Write commands, and therefore it can be used as an additional software write protection feature.

The Deep Power-Down mode is entered by driving \overline{CS} low, followed by the instruction code (Figure 2-11) onto the SI line, followed by driving \overline{CS} high.

If the \overline{CS} pin is not driven high after the eighth bit of the instruction code has been given, the device will not execute Deep power-down. Once the \overline{CS} line is driven high, there is a delay (TDP) before the current settles to its lowest consumption.

All instructions given during Deep Power-Down mode are ignored except the Read Electronic Signature Command (RDID). The RDID command will release the device from Deep power-down and outputs the electronic signature on the SO pin, and then returns the device to Standby mode after delay (TREL).

查询25AA128供应商 Deep Power-Down mode automatically releases at device power-down. Once power is restored to the device, it will power-up in the Standby mode.



2.13 Release from Deep Power-Down and Read Electronic Signature

Once a device has entered Deep Power-Down mode all instructions are ignored except the Release from Deep Power-down and Read Electronic Signature command. This command can also be used when the device is not in Deep Power-down, to read the electronic signature out on the SO pin unless another command is being executed such as Erase, Program or Write STATUS register. Release from Deep Power-Down mode and Read Electronic Signature is entered by driving CS low, followed by the RDID instruction code (Figure 2-12A/B). Then a dummy address of 24 bits (A23-A0) for the 25XX1024 and 16 bits (A15-A0) for the 25XX512 can be sent. After the last bit of the dummy address is clocked in, the 8-bit Electronic signature is clocked out on the SO pin. After the signature has been read out at least once, the sequence can be terminated by driving CS high. The device will then return to Standby mode and will wait to be selected so it can be given new instructions. If additional clock cycles are sent after the electronic signature has been read once, it will continue to output the signature on the SO line until the sequence is terminated.

FIGURE 2-12A: RELEASE FROM DEEP POWER-DOWN AND READ ELECTRONIC SIGNATURE

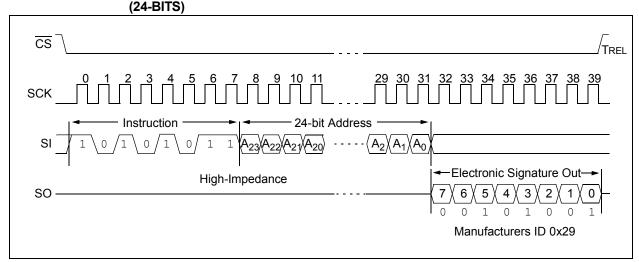
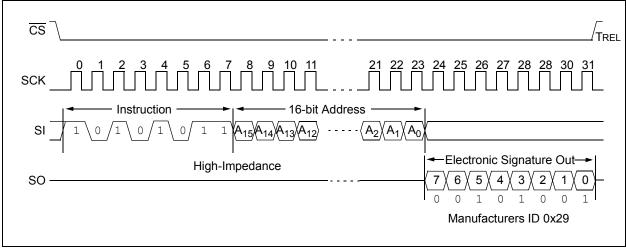
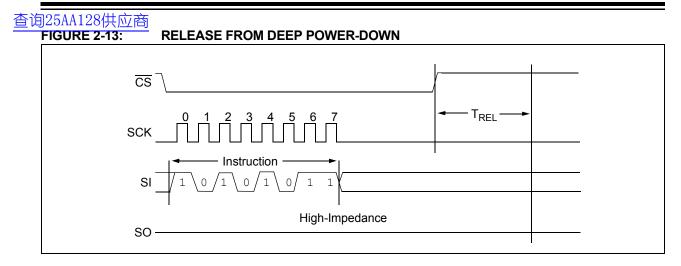


FIGURE 2-12B: RELEASE FROM DEEP POWER-DOWN AND READ ELECTRONIC SIGNATURE (16-BITS)



Driving \overline{CS} high after the 8-bit RDID command, but before the Electronic Signature has been transmitted, will still ensure the device will be taken out of Deep Power-Down mode. However, there is a delay TREL that occurs before the device returns to Standby mode (ICCS), as shown in Figure 2-13.



查询25AA128供应商

3.0 PIN DESCRIPTIONS

The descriptions of the pins are listed in Table 3-1.

TABLE 3	-1: PIN I	UNCTION TABLE
Name	Pin Number	Function
CS	1	Chip Select Input
SO	2	Serial Data Output
WP	3	Write-Protect Pin
Vss	4	Ground
SI	5	Serial Data Input
SCK	6	Serial Clock Input
HOLD	7	Hold Input
Vcc	8	Supply voltage

3.1 Chip Select (CS)

A low level on this pin selects the device. A high level deselects the device and forces it into Standby mode. However, a programming cycle which is already initiated or in progress will be completed, regardless of the \overline{CS} input signal. If \overline{CS} is brought high during a program cycle, the device will go into Standby mode as soon as the programming cycle is complete. When the device is deselected, SO goes to the high-impedance state, allowing multiple parts to share the same SPI bus. A low-to-high transition on \overline{CS} after a valid write sequence initiates an internal write cycle. After power-up, a low level on \overline{CS} is required prior to any sequence being initiated.

3.2 Serial Output (SO)

The SO pin is used to transfer data out of the EEPROM. During a read cycle, data is shifted out on this pin after the falling edge of the serial clock.

3.3 Write-Protect (WP)

The \overline{WP} pin is a hardware write-protect input pin. In the lower densities of 4 Kbits and below, a logic low on this pin will reset the write enable latch and programming will be inhibited. However, if a write cycle is already in progress, \overline{WP} going low will not change or disable the write cycle. See Table 2-4 for the Write-Protect Functionality Matrix.

In densities of 8 Kbits and higher the \overline{WP} pin is used in conjunction with the WPEN bit in the STATUS register to prohibit writes to the nonvolatile bits in the STATUS register. When \overline{WP} is low and WPEN is high, writing to the nonvolatile bits in the STATUS register are disabled. All other operations will function normally. When \overline{WP} is set to a logic high, all functions, including writes to the nonvolatile bits in the STATUS register will operate normally. If the WPEN bit is set, a logic low on the \overline{WP} pin during a STATUS register write sequence will disable writing to the STATUS register. If an internal write cycle has already begun, \overline{WP} going low will have no effect on the write in progress. The $\overline{\text{WP}}$ pin function is blocked when the WPEN bit in the STATUS register is low. This allows the user to install the EEPROM in a system with $\overline{\text{WP}}$ pin grounded and still be able to write to the STATUS register. The WP pin functions will be enabled when the WPEN bit is set to a logic high.

3.4 Serial Input (SI)

The SI pin is used to transfer data into the device. It receives instructions, addresses and data. Data is latched on the rising edge of the serial clock

3.5 Serial Clock (SCK)

The SCK is used to synchronize the communication between a master and the EEPROM. Instructions, addresses or data present on the SI pin are latched on the rising edge of the clock input, while data on the SO pin is updated after the falling edge of the clock input.

3.6 Hold (HOLD)

The HOLD pin is used to suspend transmission to the EEPROM while in the middle of a serial sequence without having to retransmit the entire sequence again. It must be held high any time this function is not being used. Once the device is selected and a serial sequence is underway, the HOLD pin may be pulled low to pause further serial communication without resetting the serial sequence. The HOLD pin must be brought low while SCK is low, otherwise the HOLD function will not be invoked until the next SCK high-tolow transition. The EEPROM must remain selected during this sequence. The SI, SCK and SO pins are in a high-impedance state during the time the device is paused and transitions on these pins will be ignored. To resume serial communication, HOLD must be brought high while the SCK pin is low, otherwise serial communication will not resume. Pulling the HOLD line low at any time will tri-state the SO line.

4.0 PACKAGING INFORMATION

4.1 Package Marking Information

8-Lead PDIP



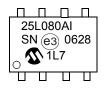
Device	Line 1 Marking	Device	Line 1 Marking
25AA010A	25AA010A	25LC010A	25LC010A
25AA020A	25AA020A	25LC020A	25LC020A
25AA040A	25AA040A	25LC040A	25LC040A
25AA080A	25AA080A	25LC080A	25LC080A
25AA080B	25AA080B	25LC080B	25LC080B
25AA160A	25AA160A	25LC160A	25LC160A
25AA160B	25AA160B	25LC160B	25LC160B
25AA320A	25AA320A	25LC320A	25LC320A
25AA640A	25AA640A	25LC640A	25LC640A
25AA128	25AA128	25LC128	25LC128
25AA256	25AA256	25LC256	25LC256
25AA512	25AA512	25LC512	25LC512
25AA1024	25AA1024	25LC1024	25LC1024

Legend	XXX Y YY WW NNN @3	Part number or part number code Year code (last digit of calendar year) Year code (last 2 digits of calendar year) Week code (week of January 1 is week '01') Alphanumeric traceability code (2 characters for small packages) Pb-free JEDEC designator for Matte Tin (Sn) plated devices
Note:	-	y small packages with no room for the Pb-free JEDEC designator marking will only appear on the outer carton or reel label.
	be carrie	nt the full Microchip part number cannot be marked on one line, it will d over to the next line, thus limiting the number of available s for customer-specific information.

查询25AA128供应商



Example: Pb-Free



8-Lead SOIC Package Marking (Pb-Free)			
Device	Line 1 Marking	Device	Line 1 Marking
25AA010A	25AA01AT	25LC010A	25LC01AT
25AA020A	25AA02AT	25LC020A	25LC02AT
25AA040A	25AA04AT	25LC040A	25LC04AT
25AA080A	25A080AT	25LC080A	25L080AT
25AA080B	25A080BT	25LC080B	25L080BT
25AA160A	25A160AT	25LC160A	25L160AT
25AA160B	25A160BT	25LC160B	25L160BT
25AA320A	25AA32AT	25LC320A	25LC32AT
25AA640A	25AA64AT	25LC640A	25LC64AT
25AA128 ⁽²⁾	25AA128T	25LC128	25LC128T
25AA256 ⁽²⁾	25AA256T	25LC256	25LC256T
25AA512 ⁽²⁾	25AA512T	25LC512	25LC512T
25AA1024 ⁽³⁾	25AA1024	25LC1024	25LC1024
ote 1: T = Temperatur			
Density availab	e in SN and SM versions.		

3: Density only available in SM.

Legend:	XXX Y YY WW NNN @3	Part number or part number code Year code (last digit of calendar year) Year code (last 2 digits of calendar year) Week code (week of January 1 is week '01') Alphanumeric traceability code (2 characters for small packages) Pb-free JEDEC designator for Matte Tin (Sn) plated devices
Note:		/ small packages with no room for the Pb-free JEDEC designator marking will only appear on the outer carton or reel label.
	be carrie	nt the full Microchip part number cannot be marked on one line, it will d over to the next line, thus limiting the number of available s for customer-specific information.

查询25AA128供应商

8-Lead TSSOP

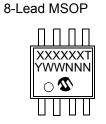


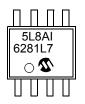
0 1628	

8-Lead TSSOP Package Marking (Pb-Free)			
Device	Line 1 Marking	Device	Line 1 Marking
25AA010A	5A1A	25LC010A	5L1A
25AA020A	5A2A	25LC020A	5L2A
25AA040A	5A4A	25LC040A	5L4A
25AA080A	5A8A	25LC080A	5L8A
25AA080B	5A8B	25LC080B	5L8B
25AA160A	5AAA	25LC160A	5LAA
25AA160B	5AAB	25LC160B	5LAB
25AA320A	5ABA	25LC320A	5LBA
25AA640A	5ACA	25LC640A	5LCA
25AA128	5AD	25LC128	5LD
25AA256	5AE	25LC256	5LE
Note: T = Temperatur	e Grade (I, E).		

Legend:	XXX Y YY WW NNN @3	Part number or part number code Year code (last digit of calendar year) Year code (last 2 digits of calendar year) Week code (week of January 1 is week '01') Alphanumeric traceability code (2 characters for small packages) Pb-free JEDEC designator for Matte Tin (Sn) plated devices
Note:		y small packages with no room for the Pb-free JEDEC designator marking will only appear on the outer carton or reel label.
	be carrie	nt the full Microchip part number cannot be marked on one line, it will d over to the next line, thus limiting the number of available s for customer-specific information.

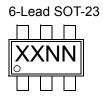
查询25AA128供应商





8-Lead MSOP Package Marking (Pb-Free)				
Device	Line 1 Marking	Device	Line 1 Marking	
25AA010A	5A1AT	25LC010A	5L1AT	
25AA020A	5A2AT	25LC020A	5L2AT	
25AA040A	5A4AT	25LC040A	5L4AT	
25AA080A	5A8AT	25LC080A	5L8AT	
25AA080B	5A8BT	25LC080B	5L8BT	
25AA160A	5AAAT	25LC160A	5LAAT	
25AA160B	5AABT	25LC160B	5LABT	
25AA320A	5ABAT	25LC320A	5LBAT	
25AA640A	5ACAT	25LC640A	5LCAT	
Note: T = Temperatur	e Grade (I, E).			

Legend	: XXX Y YY WW NNN @3	Part number or part number code Year code (last digit of calendar year) Year code (last 2 digits of calendar year) Week code (week of January 1 is week '01') Alphanumeric traceability code (2 characters for small packages) Pb-free JEDEC designator for Matte Tin (Sn) plated devices
Note:		/ small packages with no room for the Pb-free JEDEC designator marking will only appear on the outer carton or reel label.
Note:	be carrie	nt the full Microchip part number cannot be marked on one line, it will d over to the next line, thus limiting the number of available s for customer-specific information.





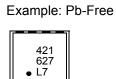
6-Lead SOT-23 Package Marking (Pb-Free)								
Device	Device I-Temp Marking Device I-Temp Marking E-Temp Marking							
25AA010A	12NN	25LC010A	15NN	16NN				
25AA020A	22NN	25LC020A	25NN	26NN				
25AA040A	32NN	25LC040A	35NN	36NN				

Legend	: XXX Y YY WW NNN @3	Part number or part number code Year code (last digit of calendar year) Year code (last 2 digits of calendar year) Week code (week of January 1 is week '01') Alphanumeric traceability code (2 characters for small packages) Pb-free JEDEC designator for Matte Tin (Sn) plated devices
Note:		y small packages with no room for the Pb-free JEDEC designator marking will only appear on the outer carton or reel label.
Note:	be carrie	nt the full Microchip part number cannot be marked on one line, it will d over to the next line, thus limiting the number of available s for customer-specific information.

查询25AA128供应商

8-Lead 2x3 DFN





8-Lead 2x3 DFN Package Marking (Pb-Free)						
Device	I-Temp Marking	I-Temp Marking	E-Temp Marking			
25AA010A	401	25LC010A	404	405		
25AA020A	411	25LC020A	414	415		
25AA040A 421 25LC040A		25LC040A	424	425		
Note: NN = Alphanumeric Traceability Code.						

Legend	: XXX Y YY WW NNN @3	Part number or part number code Year code (last digit of calendar year) Year code (last 2 digits of calendar year) Week code (week of January 1 is week '01') Alphanumeric traceability code (2 characters for small packages) Pb-free JEDEC designator for Matte Tin (Sn) plated devices
Note:		/ small packages with no room for the Pb-free JEDEC designator marking will only appear on the outer carton or reel label.
Note:	be carrie	nt the full Microchip part number cannot be marked on one line, it will d over to the next line, thus limiting the number of available s for customer-specific information.

8-Lead 6x5 DFN-S

XXXXXXX XXXXXXX XXYYWW MNN

25AA128 XXX-I/
MF0610
S 017

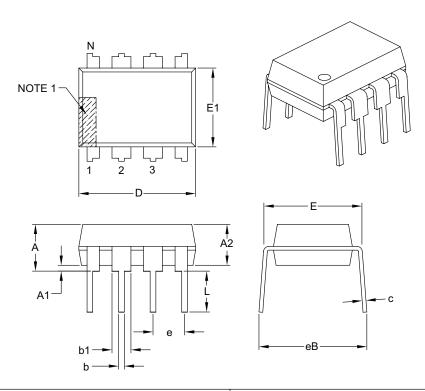
8-Lead 6x5 DFN-S Package Marking (Pb-Free)							
Device Line 1 Marking Device Line 1 Marking							
25AA128	25AA128	25LC128	25LC128				
25AA256	25AA256	25LC256	25LC256				
25AA512	25AA512	25LC512	25LC512				
25AA1024 25AA1024 25LC1024 25LC1024							
Note: T = Temperature Grade (I, E)							

Legend	: XXX Y YY WW NNN @3	Part number or part number code Year code (last digit of calendar year) Year code (last 2 digits of calendar year) Week code (week of January 1 is week '01') Alphanumeric traceability code (2 characters for small packages) Pb-free JEDEC designator for Matte Tin (Sn) plated devices
Note:	-	/ small packages with no room for the Pb-free JEDEC designator marking will only appear on the outer carton or reel label.
Note:	be carrie	nt the full Microchip part number cannot be marked on one line, it will d over to the next line, thus limiting the number of available s for customer-specific information.

查询25AA128供应商

8-Lead Plastic Dual In-Line (P) – 300 mil Body [PDIP]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units		INCHES		
Dimension	n Limits	MIN	NOM	MAX	
Number of Pins	N		8		
Pitch	е		.100 BSC		
Top to Seating Plane	A	-	-	.210	
Molded Package Thickness	A2	.115	.130	.195	
Base to Seating Plane	A1	.015	-	-	
Shoulder to Shoulder Width	E	.290	.310	.325	
Molded Package Width	E1	.240	.250	.280	
Overall Length	D	.348	.365	.400	
Tip to Seating Plane	L	.115	.130	.150	
Lead Thickness	С	.008	.010	.015	
Upper Lead Width	b1	.040	.060	.070	
Lower Lead Width	b	.014	.018	.022	
Overall Row Spacing §	eВ	_	-	.430	

Notes:

1. Pin 1 visual index feature may vary, but must be located with the hatched area.

2. § Significant Characteristic.

3. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010" per side.

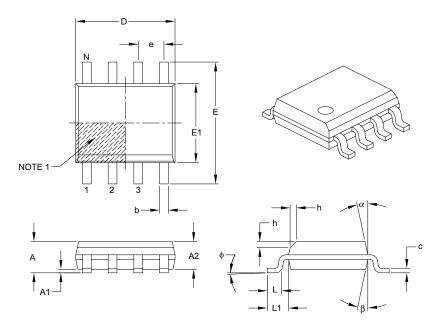
4. Dimensioning and tolerancing per ASME Y14.5M.

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing C04-018B

8-Lead Plastic Small Outline (SN) – Narrow, 3.90 mm Body [SOIC]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units		MILLIMETERS		
	Dimension Limits	MIN	NOM	MAX	
Number of Pins	N		8		
Pitch	e	1.27 BSC			
Overall Height	A	-	-	1.75	
Molded Package Thickness	A2	1.25	-	-	
Standoff §	A1	0.10	-	0.25	
Overall Width	E	6.00 BSC			
Molded Package Width	E1	3.90 BSC			
Overall Length	D		4.90 BSC		
Chamfer (optional)	h	0.25	-	0.50	
Foot Length	L	0.40	-	1.27	
Footprint	L1	1.04 REF			
Foot Angle	φ	0°	-	8°	
Lead Thickness	С	0.17	-	0.25	
Lead Width	b	0.31	-	0.51	
Mold Draft Angle Top	α	5°	-	15°	
Mold Draft Angle Bottom	β	5°	-	15°	

Notes:

1. Pin 1 visual index feature may vary, but must be located within the hatched area.

2. § Significant Characteristic.

3. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.15 mm per side.

- 4. Dimensioning and tolerancing per ASME Y14.5M.
 - BSC: Basic Dimension. Theoretically exact value shown without tolerances.

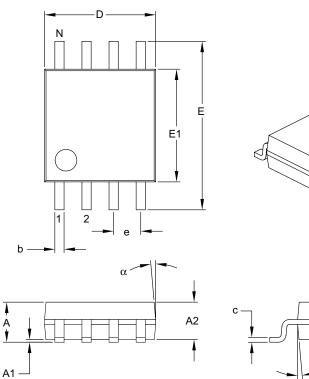
REF: Reference Dimension, usually without tolerance, for information purposes only.

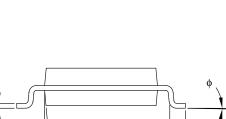
Microchip Technology Drawing C04-057B

查询25AA128供应商

8-Lead Plastic Small Outline (SM) – Medium, 5.28 mm Body [SOIJ]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging





ß

	Units		MILLIMETERS		
	Dimension Limits			MAX	
Number of Pins	N		8		
Pitch	e		1.27 BSC		
Overall Height	A	1.77	-	2.03	
Molded Package Thickness	A2	1.75	-	1.98	
Standoff §	A1	0.05	-	0.25	
Overall Width	E	7.62	-	8.26	
Molded Package Width	E1	5.11	-	5.38	
Overall Length	D	5.13	-	5.33	
Foot Length	L	0.51	-	0.76	
Foot Angle	φ	0°	-	8°	
Lead Thickness	С	0.15	-	0.25	
Lead Width	b	0.36	-	0.51	
Mold Draft Angle Top	α	-	-	15°	
Mold Draft Angle Bottom	β	_	-	15°	

Notes:

1. SOIJ, JEITA/EIAJ Standard, formerly called SOIC.

2. § Significant Characteristic.

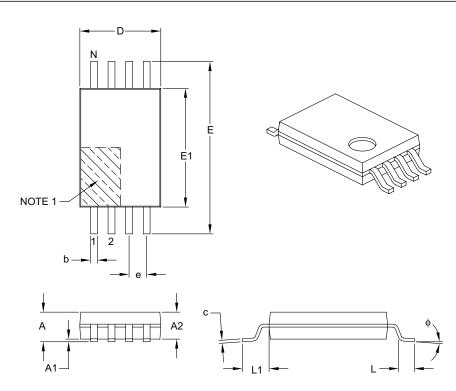
A ١

3. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.25 mm per side.

Microchip Technology Drawing C04-056B

8-Lead Plastic Thin Shrink Small Outline (ST) – 4.4 mm Body [TSSOP]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	MILLIMETERS			
Dimensio	Dimension Limits		NOM	MAX
Number of Pins	N	8		
Pitch	е		0.65 BSC	
Overall Height	Α	-	-	1.20
Molded Package Thickness	A2	0.80	1.00	1.05
Standoff	A1	0.05	-	0.15
Overall Width	E	6.40 BSC		
Molded Package Width	E1	4.30	4.40	4.50
Molded Package Length	D	2.90	3.00	3.10
Foot Length	L	0.45	0.60	0.75
Footprint	L1	1.00 REF		
Foot Angle	¢	0°	-	8°
Lead Thickness	С	0.09	-	0.20
Lead Width	b	0.19	_	0.30

Notes:

1. Pin 1 visual index feature may vary, but must be located within the hatched area.

2. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.15 mm per side.

- 3. Dimensioning and tolerancing per ASME Y14.5M.
 - BSC: Basic Dimension. Theoretically exact value shown without tolerances.

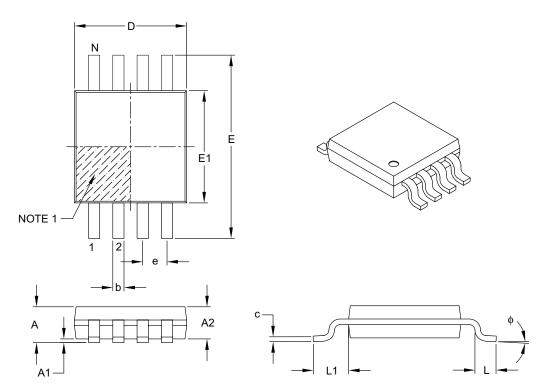
REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing C04-086B

查询25AA128供应商

8-Lead Plastic Micro Small Outline Package (MS) [MSOP]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units		MILLIMETERS	6
Dimensi	on Limits	MIN	NOM	MAX
Number of Pins	N		8	
Pitch	е		0.65 BSC	
Overall Height	Α	-	-	1.10
Molded Package Thickness	A2	0.75	0.85	0.95
Standoff	A1	0.00	-	0.15
Overall Width	E		4.90 BSC	
Molded Package Width	E1		3.00 BSC	
Overall Length	D		3.00 BSC	
Foot Length	L	0.40	0.60	0.80
Footprint	L1		0.95 REF	
Foot Angle	φ	0°	-	8°
Lead Thickness	с	0.08	-	0.23
Lead Width	b	0.22	_	0.40

Notes:

1. Pin 1 visual index feature may vary, but must be located within the hatched area.

2. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.15 mm per side.

3. Dimensioning and tolerancing per ASME Y14.5M.

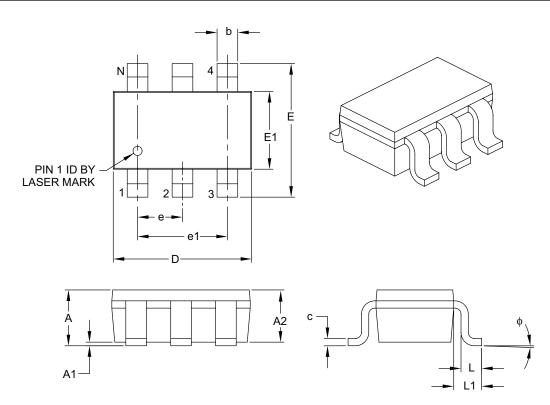
BSC: Basic Dimension. Theoretically exact value shown without tolerances.

REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing C04-111B

6-Lead Plastic Small Outline Transistor (OT) [SOT-23]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units		MILLIMETERS	6
Dimensio	on Limits	MIN	NOM	MAX
Number of Pins	N		6	
Pitch	е	0.95 BSC		
Outside Lead Pitch	e1	1.90 BSC		
Overall Height	Α	0.90	-	1.45
Molded Package Thickness	A2	0.89	-	1.30
Standoff	A1	0.00	-	0.15
Overall Width	E	2.20	-	3.20
Molded Package Width	E1	1.30	-	1.80
Overall Length	D	2.70	-	3.10
Foot Length	L	0.10	-	0.60
Footprint	L1	0.35	-	0.80
Foot Angle	φ	0°	-	30°
Lead Thickness	С	0.08	-	0.26
Lead Width	b	0.20	-	0.51

Notes:

1. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.127 mm per side.

2. Dimensioning and tolerancing per ASME Y14.5M.

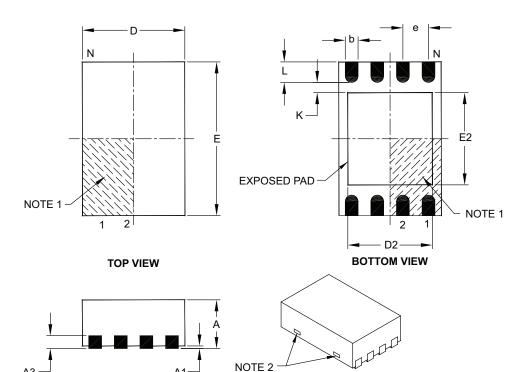
BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing C04-028B

查询25AA128供应商

8-Lead Plastic Dual Flat, No Lead Package (MC) – 2x3x0.9 mm Body [DFN]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units		MILLIMETERS	6
Dimensio	n Limits	MIN	NOM	MAX
Number of Pins	N		8	
Pitch	е		0.50 BSC	
Overall Height	Α	0.80	0.90	1.00
Standoff	A1	0.00	0.02	0.05
Contact Thickness	A3		0.20 REF	
Overall Length	D		2.00 BSC	
Overall Width	E		3.00 BSC	
Exposed Pad Length	D2	1.30	-	1.75
Exposed Pad Width	E2	1.50	-	1.90
Contact Width	b	0.18	0.25	0.30
Contact Length	L	0.30	0.40	0.50
Contact-to-Exposed Pad	К	0.20	-	-

Notes:

- 1. Pin 1 visual index feature may vary, but must be located within the hatched area.
- 2. Package may have one or more exposed tie bars at ends.
- 3. Package is saw singulated.

A3

- 4. Dimensioning and tolerancing per ASME Y14.5M.
 - BSC: Basic Dimension. Theoretically exact value shown without tolerances.

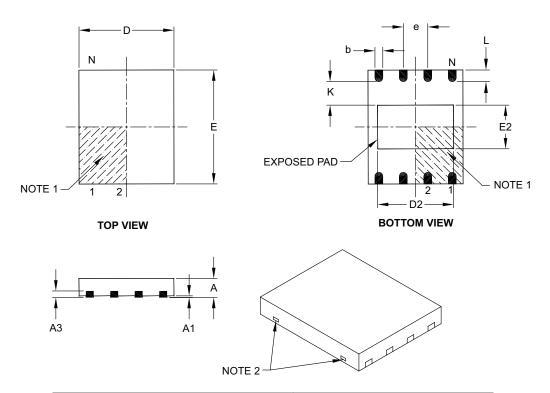
REF: Reference Dimension, usually without tolerance, for information purposes only.

A1

Microchip Technology Drawing C04-123B

8-Lead Plastic Dual Flat, No Lead Package (MF) – 6x5 mm Body [DFN-S]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units		MILLIMETERS	3
Dimension	n Limits	MIN	NOM	MAX
Number of Pins	N		8	
Pitch	е		1.27 BSC	
Overall Height	Α	0.80	0.85	1.00
Standoff	A1	0.00	0.01	0.05
Contact Thickness	A3		0.20 REF	
Overall Length	D		5.00 BSC	
Overall Width	E		6.00 BSC	
Exposed Pad Length	D2	3.90	4.00	4.10
Exposed Pad Width	E2	2.20	2.30	2.40
Contact Width	b	0.35	0.40	0.48
Contact Length	L	0.50	0.60	0.75
Contact-to-Exposed Pad	K	0.20	_	-

Notes:

1. Pin 1 visual index feature may vary, but must be located within the hatched area.

- 2. Package may have one or more exposed tie bars at ends.
- 3. Package is saw singulated.
- 4. Dimensioning and tolerancing per ASME Y14.5M.
 - BSC: Basic Dimension. Theoretically exact value shown without tolerances.

REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing C04-122B

查询25AA128供应商 APPENDIX A: REVISION HISTORY

Revision A (05/2007)

Original release of document. (Package Drawings Rev. AP)

Revision B (06/2007)

- Updated the 6-Lead SOT-23 packaging information
- Updated the Product Identification System information
- Minor corrections throughout document

Revision C (08/2007)

Removed "Preliminary" status for 512, 640A and 1024 devices.

查询25AA128供应商 THE MICROCHIP WEB SITE

Microchip provides online support via our WWW site at www.microchip.com. This web site is used as a means to make files and information easily available to customers. Accessible by using your favorite Internet browser, the web site contains the following information:

- Product Support Data sheets and errata, application notes and sample programs, design resources, user's guides and hardware support documents, latest software releases and archived software
- General Technical Support Frequently Asked Questions (FAQ), technical support requests, online discussion groups, Microchip consultant program member listing
- Business of Microchip Product selector and ordering guides, latest Microchip press releases, listing of seminars and events, listings of Microchip sales offices, distributors and factory representatives

CUSTOMER CHANGE NOTIFICATION SERVICE

Microchip's customer notification service helps keep customers current on Microchip products. Subscribers will receive e-mail notification whenever there are changes, updates, revisions or errata related to a specified product family or development tool of interest.

To register, access the Microchip web site at www.microchip.com, click on Customer Change Notification and follow the registration instructions.

CUSTOMER SUPPORT

Users of Microchip products can receive assistance through several channels:

- Distributor or Representative
- · Local Sales Office
- Field Application Engineer (FAE)
- Technical Support

Customers should contact their distributor, representative or field application engineer (FAE) for support. Local sales offices are also available to help customers. A listing of sales offices and locations is included in the back of this document.

Technical support is available through the web site at: http://support.microchip.com

查询25AA128供应商 READER RESPONSE

It is our intention to provide you with the best documentation possible to ensure successful use of your Microchip product. If you wish to provide your comments on organization, clarity, subject matter, and ways in which our documentation can better serve you, please FAX your comments to the Technical Publications Manager at (480) 792-4150.

Please list the following information, and use this outline to provide us with your comments about this document.

To:	Technical Publications Manager	Total Pages Sent
RE:	Reader Response	
Fron	n: Name	
	Telephone: ()	
laaA	ication (optional):	FAX: ()
	ld you like a reply?YN	
Devi	ce: 25AAXXXX/25LCXXXX	Literature Number: DS22040C
Que	stions:	
1. \	What are the best features of this do	cument?
-		
-		
2. 1	How does this document meet your r	nardware and software development needs?
-		
3. I	Do you find the organization of this d	ocument easy to follow? If not, why?
-		
-		
4. \	what additions to the document do y	ou think would enhance the structure and subject?
-		
5. \	What deletions from the document co	ould be made without affecting the overall usefulness?
-		
-		
6. I	is there any incorrect or misleading in	nformation (what and where)?
-		
7. I	How would you improve this docume	nt?
-		
-		

查询25AA128供应商 PRODUCT IDENTIFICATION SYSTEM

To order or obtain information, e.g., on pricing or delivery, refer to the factory or the listed sales office.

ART NO.	¥ ¥ <u>⁄××</u>	Examples:
evice Part Number	Packaging Temperature Package Medium Range	 a) 25AA010A-I/SN: 1K b) 25AA040A-I/MS: 4K c) 25LC040AT-I/OT: 4K d) 25LC1024-I/SM: 1M e) 25LC040AT-I/MC
Device:	EEPROM Series – 25 Voltage – AA = 1.8V-5.5V LC = 2.5V-5.5V	
Density:	010A = 1 Kbit 020A = 2 Kbit 040A = 4 Kbit 080A = 8 Kbit 080B = 8 Kbit 160A = 16 Kbit 160B = 16 Kbit 320A = 32 Kbit 640A = 64 Kbit 128 = 128 Kbit 256 = 256 Kbit 512 = 512 Kbit 1024 = 1024 Kbit (1Mbit)	
Temperature	$I = -40^{\circ}C \text{ to } +85^{\circ}C$	
Range:	$E = -40^{\circ}C \text{ to } +125^{\circ}C$	
Packaging	T = Tape and Reel (T/R)	
Medium:	Blank = Std. Pkg.	
Package:	P=8-lead Plastic DIP (300 mil body)SN=8-lead Plastic SOIC (3.90 mm body)SM=8-lead Plastic SOIC (5.28 mm body)ST=8-lead Plastic TSSOP (4.4 mm)MS=8-lead Plastic MSOP (3.0 mm)MC=8-lead 2x3 mm DFN (T/R only)MF=8-lead 6x5 mm DFNOT=6-lead SOT-23 (T/R only)	

查询25AA128供应商 NOTES:

Note the following details of the code protection feature on Microchip devices:

- Microchip products meet the specification contained in their particular Microchip Data Sheet.
- Microchip believes that its family of products is one of the most secure families of its kind on the market today, when used in the intended manner and under normal conditions.
- There are dishonest and possibly illegal methods used to breach the code protection feature. All of these methods, to our knowledge, require using the Microchip products in a manner outside the operating specifications contained in Microchip's Data Sheets. Most likely, the person doing so is engaged in theft of intellectual property.
- Microchip is willing to work with the customer who is concerned about the integrity of their code.
- Neither Microchip nor any other semiconductor manufacturer can guarantee the security of their code. Code protection does not mean that we are guaranteeing the product as "unbreakable."

Code protection is constantly evolving. We at Microchip are committed to continuously improving the code protection features of our products. Attempts to break Microchip's code protection feature may be a violation of the Digital Millennium Copyright Act. If such acts allow unauthorized access to your software or other copyrighted work, you may have a right to sue for relief under that Act.

Information contained in this publication regarding device applications and the like is provided only for your convenience and may be superseded by updates. It is your responsibility to ensure that your application meets with your specifications. MICROCHIP MAKES NO REPRESENTATIONS OR WARRANTIES OF ANY KIND WHETHER EXPRESS OR IMPLIED, WRITTEN OR ORAL, STATUTORY OR OTHERWISE, RELATED TO THE INFORMATION, INCLUDING BUT NOT LIMITED TO ITS CONDITION, QUALITY, PERFORMANCE, MERCHANTABILITY OR FITNESS FOR PURPOSE. Microchip disclaims all liability arising from this information and its use. Use of Microchip devices in life support and/or safety applications is entirely at the buyer's risk, and the buyer agrees to defend, indemnify and hold harmless Microchip from any and all damages, claims, suits, or expenses resulting from such use. No licenses are conveyed, implicitly or otherwise, under any Microchip intellectual property rights.

Trademarks

The Microchip name and logo, the Microchip logo, Accuron, dsPIC, KEELOQ, KEELOQ logo, microID, MPLAB, PIC, PICmicro, PICSTART, PRO MATE, rfPIC and SmartShunt are registered trademarks of Microchip Technology Incorporated in the U.S.A. and other countries.

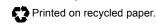
AmpLab, FilterLab, Linear Active Thermistor, Migratable Memory, MXDEV, MXLAB, SEEVAL, SmartSensor and The Embedded Control Solutions Company are registered trademarks of Microchip Technology Incorporated in the U.S.A.

Analog-for-the-Digital Age, Application Maestro, CodeGuard, dsPICDEM, dsPICDEM.net, dsPICworks, dsSPEAK, ECAN, ECONOMONITOR, FanSense, FlexROM, fuzzyLAB, In-Circuit Serial Programming, ICSP, ICEPIC, Mindi, MiWi, MPASM, MPLAB Certified logo, MPLIB, MPLINK, PICkit, PICDEM, PICDEM.net, PICLAB, PICtail, PowerCal, PowerInfo, PowerMate, PowerTool, REAL ICE, rfLAB, Select Mode, Smart Serial, SmartTel, Total Endurance, UNI/O, WiperLock and ZENA are trademarks of Microchip Technology Incorporated in the U.S.A. and other countries.

SQTP is a service mark of Microchip Technology Incorporated in the U.S.A.

All other trademarks mentioned herein are property of their respective companies.

© 2007, Microchip Technology Incorporated, Printed in the U.S.A., All Rights Reserved.



QUALITY MANAGEMENT SYSTEM CERTIFIED BY DNV ISO/TS 16949:2002 Microchip received ISO/TS-16949:2002 certification for its worldwide headquarters, design and wafer fabrication facilities in Chandler and Tempe, Arizona; Gresham, Oregon and design centers in California and India. The Company's quality system processes and procedures are for its PIC® MCUs and dsPIC® DSCs, KEELOQ® code hopping devices, Serial EEPROMs, microperipherals, nonvolatile memory and analog products. In addition, Microchip's quality system for the design and manufacture of development systems is ISO 9001:2000 certified.



WORLDWIDE SALES AND SERVICE

AMERICAS

Corporate Office 2355 West Chandler Blvd. Chandler, AZ 85224-6199 Tel: 480-792-7200 Fax: 480-792-7277 Technical Support: http://support.microchip.com Web Address: www.microchip.com

Atlanta Duluth, GA Tel: 678-957-9614 Fax: 678-957-1455

Boston Westborough, MA Tel: 774-760-0087 Fax: 774-760-0088

Chicago Itasca, IL Tel: 630-285-0071 Fax: 630-285-0075

Dallas Addison, TX Tel: 972-818-7423 Fax: 972-818-2924

Detroit Farmington Hills, MI Tel: 248-538-2250 Fax: 248-538-2260

Kokomo Kokomo, IN Tel: 765-864-8360 Fax: 765-864-8387

Los Angeles Mission Viejo, CA Tel: 949-462-9523 Fax: 949-462-9608

Santa Clara Santa Clara, CA Tel: 408-961-6444 Fax: 408-961-6445

Toronto Mississauga, Ontario, Canada Tel: 905-673-0699 Fax: 905-673-6509

ASIA/PACIFIC

Asia Pacific Office Suites 3707-14, 37th Floor Tower 6, The Gateway Harbour City, Kowloon Hong Kong Tel: 852-2401-1200 Fax: 852-2401-3431

Australia - Sydney Tel: 61-2-9868-6733 Fax: 61-2-9868-6755

China - Beijing Tel: 86-10-8528-2100 Fax: 86-10-8528-2104

China - Chengdu Tel: 86-28-8665-5511 Fax: 86-28-8665-7889

China - Fuzhou Tel: 86-591-8750-3506 Fax: 86-591-8750-3521

China - Hong Kong SAR Tel: 852-2401-1200 Fax: 852-2401-3431

China - Qingdao Tel: 86-532-8502-7355 Fax: 86-532-8502-7205

China - Shanghai Tel: 86-21-5407-5533 Fax: 86-21-5407-5066

China - Shenyang Tel: 86-24-2334-2829 Fax: 86-24-2334-2393

China - Shenzhen Tel: 86-755-8203-2660 Fax: 86-755-8203-1760

China - Shunde Tel: 86-757-2839-5507 Fax: 86-757-2839-5571

China - Wuhan Tel: 86-27-5980-5300 Fax: 86-27-5980-5118

China - Xian Tel: 86-29-8833-7252 Fax: 86-29-8833-7256

ASIA/PACIFIC

India - Bangalore Tel: 91-80-4182-8400 Fax: 91-80-4182-8422

India - New Delhi Tel: 91-11-4160-8631 Fax: 91-11-4160-8632

India - Pune Tel: 91-20-2566-1512 Fax: 91-20-2566-1513

Japan - Yokohama Tel: 81-45-471- 6166 Fax: 81-45-471-6122

Korea - Daegu Tel: 82-53-744-4301 Fax: 82-53-744-4302

Korea - Seoul Tel: 82-2-554-7200 Fax: 82-2-558-5932 or 82-2-558-5934

Malaysia - Penang Tel: 60-4-646-8870 Fax: 60-4-646-5086

Philippines - Manila Tel: 63-2-634-9065 Fax: 63-2-634-9069

Singapore Tel: 65-6334-8870 Fax: 65-6334-8850

Taiwan - Hsin Chu Tel: 886-3-572-9526 Fax: 886-3-572-6459

Taiwan - Kaohsiung Tel: 886-7-536-4818 Fax: 886-7-536-4803

Taiwan - Taipei Tel: 886-2-2500-6610 Fax: 886-2-2508-0102

Thailand - Bangkok Tel: 66-2-694-1351 Fax: 66-2-694-1350

EUROPE

Austria - Wels Tel: 43-7242-2244-39 Fax: 43-7242-2244-393 Denmark - Copenhagen Tel: 45-4450-2828 Fax: 45-4485-2829

France - Paris Tel: 33-1-69-53-63-20 Fax: 33-1-69-30-90-79

Germany - Munich Tel: 49-89-627-144-0 Fax: 49-89-627-144-44

Italy - Milan Tel: 39-0331-742611 Fax: 39-0331-466781

Netherlands - Drunen Tel: 31-416-690399 Fax: 31-416-690340

Spain - Madrid Tel: 34-91-708-08-90 Fax: 34-91-708-08-91

UK - Wokingham Tel: 44-118-921-5869 Fax: 44-118-921-5820

06/25/07